Application/Control No. Applicant(s)/Patent Under Reexamination 10/659,293 NINOMIYA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Mark A. Chapman 1756 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 05-2003 US-6,569,589 Inaba et al. Α 430/108.22 US-6,528,224 03-2003 Ohno et al. В 430/108.8 С US-US-D US-Ε US-F US-G US-H USı US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS**

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